

Electronic Supplementary Information

Novel high-efficiency visible-light response $\text{Ag}_4(\text{GeO}_4)$ photocatalyst

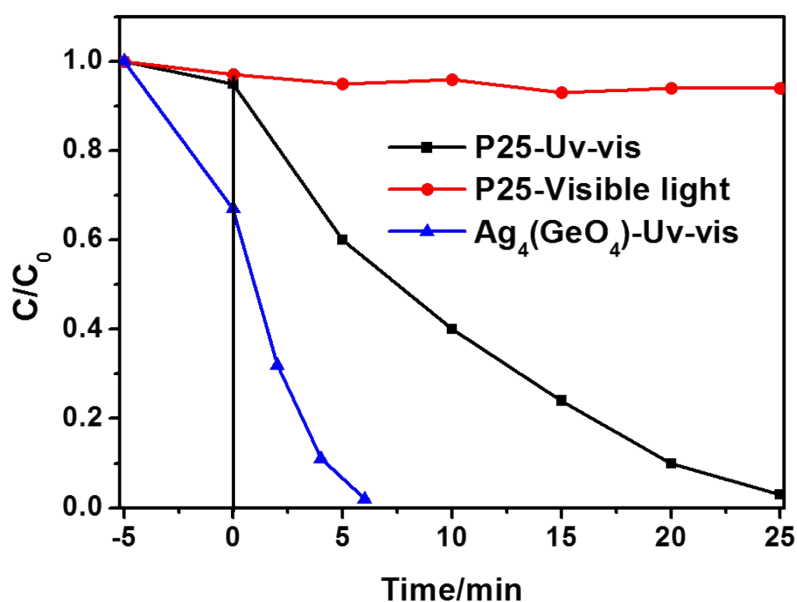


Fig.S1 Photodegradation of MB solution under visible or UV-Vis light irradiation with commercial P25 and $\text{Ag}_4(\text{GeO}_4)$

	$\text{Ag}_4(\text{GeO}_4)$	Ag_2O	C_3N_4
k	0.125	0.043	0.021
k_{BET}	0.00665	0.00796	0.0015

Table1. Degradation constants of the samples before (k) and after (k_{BET}) being normalized with surface areas.

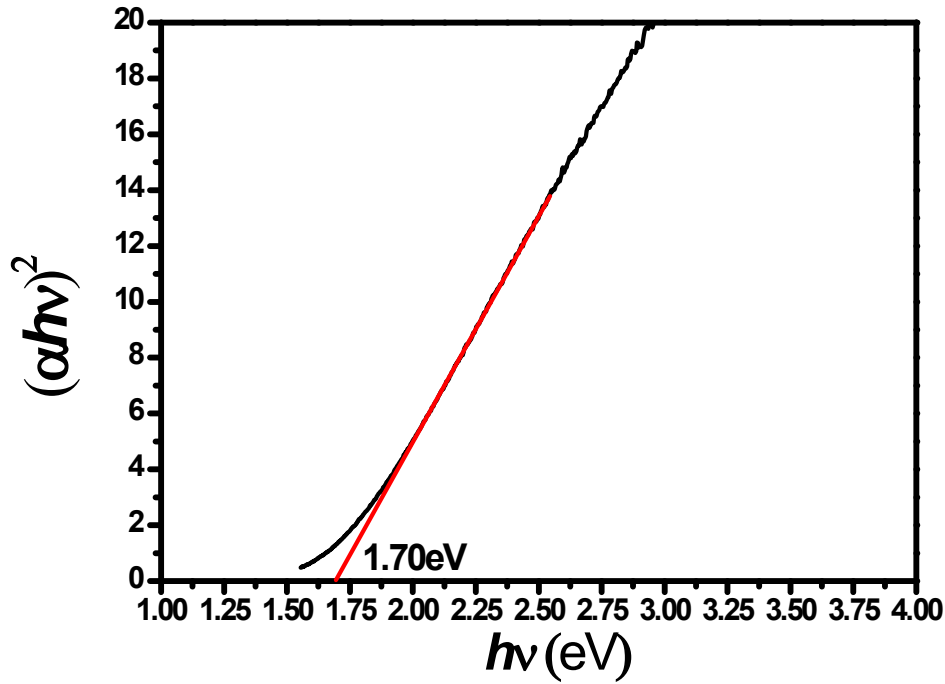


Fig.S2 $(\alpha h\nu)^2$ versus $(h\nu)$ plot of the $\text{Ag}_4(\text{GeO}_4)$ sample.

Calculations of the VB and CB edges of $\text{Ag}_4(\text{GeO}_4)$

For a semiconductor, the absorbance near the absorption edge is described by the

formula: $\alpha h\nu = A(h\nu - E_g)^{n/2}$, where α is the absorption coefficient, $h\nu$ is the photon energy, A is a constant and E_g is the band gap. For $\text{Ag}_4(\text{GeO}_4)$, $n = 4$ for indirect transition, the result is shown in Fig.S2.

The VB edge of a semiconductor at the point of zero charge (E_{VB}^0) is empirically expressed as^[1-3],

$$E_{VB}^0 = \chi_{\text{comp}} - 2.30RT (\text{pH}_{\text{zpc}} - \text{pH}) / F - E^e - \frac{1}{2}E_g \quad (1)$$

In this formular R is the gas constant, T is temperature, and F is Faraday constant. E_g is the band gap of the semiconductor, and E^e the energy of the free electrons on the hydrogen scale (i. e., $E^e = 4.5$ eV). Under the reasonable assumption that the solution's pH value at the zero point of charge, pH_{ZPC} , is very close to the solution's pH value, pH , we obtain

$$E_{VB}^0 \approx E_{VB} \approx \chi_{\text{comp}} - E^e - \frac{1}{2}E_g \quad (2)$$

χ_{comp} is the electronegativity of a compound which is given by the geometric mean of the electronegativity of the constituent atoms, which expressed as the mean geometric of absolute

electronegativity of all the constituent atoms, E_e means the free electrons energy contrasting to the hydrogen scale (4.5 eV vs NHE), E_g is the semiconductor band gap energy. that is ⁴,

$$\chi_{\text{comp}} = \sqrt[N]{\chi_1^r \chi_2^s \cdots \chi_3^p \chi_4^q}, \quad (3)$$

where χ and N are the electro negativity of the constituent atom, the number of the species, and the total number of atoms in the compound, respectively . The superscripts r, s, p, \dots, q refer to the numbers of the atoms 1, 2, ..., $n-1$ and n , respectively in the molecule, respectively, so that $r + s + \cdots + p + q = N$. From its UV/Vis diffuse reflectance spectrum, the band gap of $\text{Ag}_9(\text{SiO}_4)_2\text{NO}_3$ is estimated to be 1.70 eV. The values of O, Ge and Ag are 7.54, 4.78, 4.44 respectively ⁵.

Thus, from Eq. 2, the VB edge of $\text{Ag}_4(\text{GeO}_4)$ is estimated to be 2.01 eV with respect to the normal hydrogen electrode (NHE) Consequently, on the basis of its band gap (1.70 eV), the VB edge of $\text{Ag}_4(\text{GeO}_4)$ is determined to be 0.31 eV with respect to the NHE.

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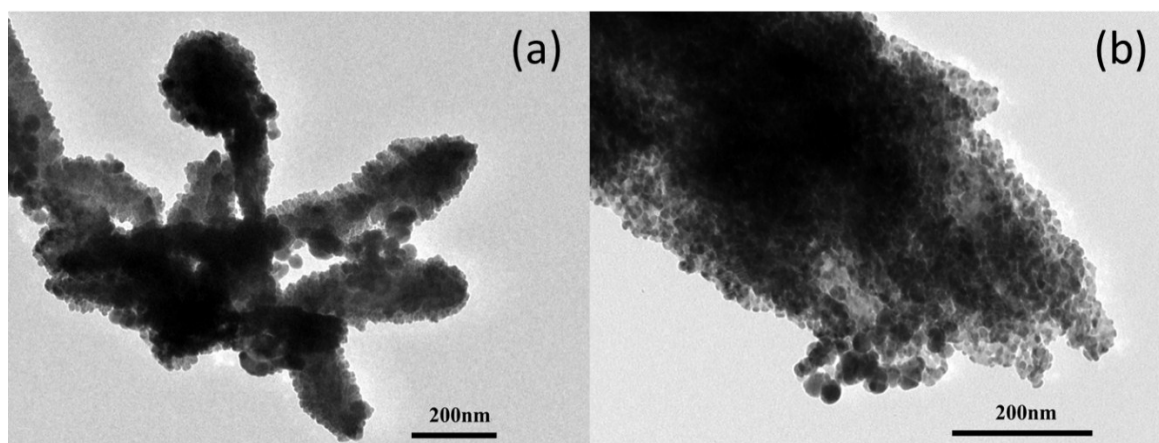


Fig.S3 TEM images of the $\text{Ag}_4(\text{GeO}_4)$ sample.

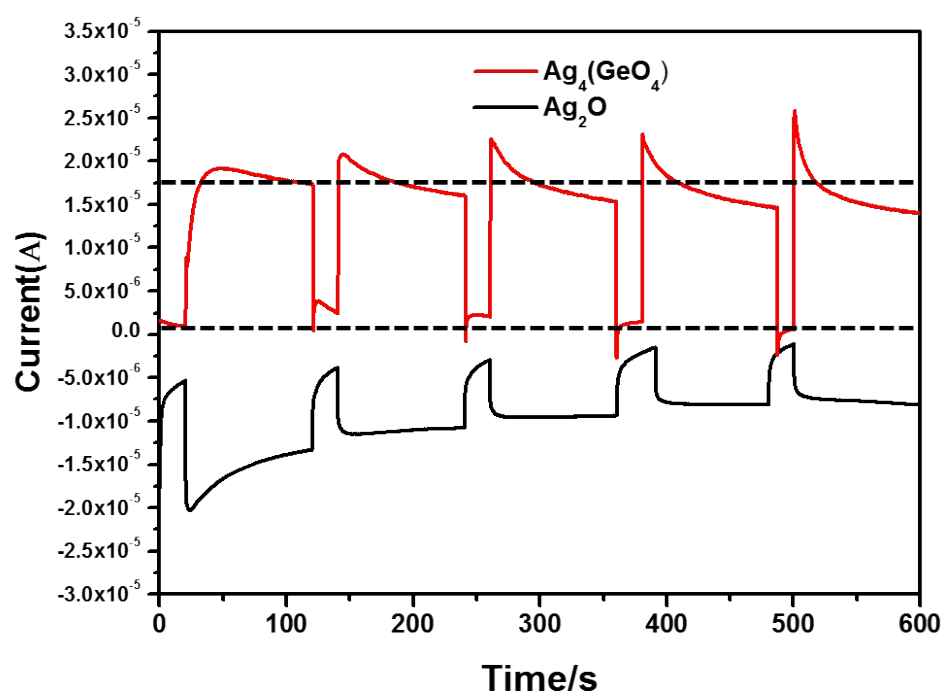


Fig.S4 Photocurrents of the $\text{Ag}_4(\text{GeO}_4)$ and Ag_2O sample.